MIL-S-19500/41B(EL)
AMENDMENT-1
15 August 1967

MILITARY SPECIFICATION

SEMICONDUCTOR DEVICE, TRANSISTOR, PNP, GERMANIUM, SWITCHING TYPES 2N425, 2N426, 2N427

This Amendment forms a part of Military Specification MIL-S-19500/41B(EL), 18 May 1967.

Page 1, paragraph 1.3 Table, item I_C: Replace Unit "Adc" with: "mAdc."

Page 1, paragraph 1.4 Table, item h_{FE}: Replace condition "I_C =-1 mAdc" with: "I_B= -1 mAdc."

Page 6, Table I, Subgroup 3, first item 3076: In the Conditions column, replace "I_C = -1.0 mAdc" with: "I_B = -1.0 mAdc".

Page 6, Table I, Subgroup 3, second item 3076: In the Conditions column, replace "I_C = -10 mAdc" with: "I_B = -10 mAdc".

Page 7, Table I, Subgroup 6, High-Temperature Operation test item 3076 and Low-Temperature Operation test item 3076: In the Conditions column, replace "I_C = -1.0 mAdc" with: "I_B = -1.0 mAdc".

Page 8, Table II, Subgroup 2 End-Point Tests, item 3076: In the Conditions column, replace "I_C = -1.0 mAdc" with: "I_B = -1.0 mAdc".

Page 9, Table II, Subgroup 6 End-Point Tests, item 3076: In the Conditions column, replace "I_C = -1.0 mAdc" with: "I_B = -1.0 mAdc."

Page 11, Table III, Subgroup 1 End-Point Tests, item 3076: In the Conditions column, replace "I_C = -1.0 mAdc" with: "I_B = -1.0 mAdc".

Custodian:
Army-EL

Preparing activity:
Army-EL

Project No. 5961-A128

*U.S. GOVERNMENT PRINTING OFFICE: 1967-301-512/1686

FSC-5961